Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/645,672	TAKAHASHI ET AL.	
Examiner	Art Unit	
Sherali Ishrat	2621	

	SEAR	SEARCHED			
Class	Subclass	Date	Examiner		
382	232-233 298-300 236	12/5/2005	IS		
348	14.01-	12/5/2005	IS		
	14.16				
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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EAST, IEEE		5/12/2005	IS